

MBN750H65E2

Silicon N-channel IGBT 6500V E2 version

FEATURES

- * Soft switching behavior & low conduction loss: Soft low-injection punch-through High conductivity IGBT.
- * Low driving power due to low input capacitance MOS gate.
- * Low noise recovery: Ultra soft fast recovery diode.
- * High thermal fatigue durability:
($\Delta T_c=70K$, $N>30,000$ cycles)
AlSiC base-plate/AlN substrate

ABSOLUTE MAXIMUM RATINGS (T_C=25°C)

Item	Symbol	Unit	MBN750H65E2	
Collector Emitter Voltage	T _j =125°C	V _{CES}	V	6,500
	T _j =25°C			6,500
	T _j =-40°C			6,000
Gate Emitter Voltage	V _{GES}	V	±20	
Collector Current	DC	I _C	A	750 (T _C =80°C)
	1ms	I _{Cp}		1,500
Forward Current	DC	I _F	A	750
	1ms	I _{FM}		1,500
Junction Temperature	T _j	°C	-40 ~ +125	
Storage Temperature	T _{stg}	°C	-50 ~ +125	
Isolation Voltage	V _{ISO}	V _{RMS}	10,200 (AC 1 minute)	
Screw Torque	Terminals (M4/M8)	-	N·m	2/10 (1)
	Mounting (M6)	-		6 (2)

Notes: (1) Recommended Value 1.8±0.2/9±1N·m

(2) Recommended Value 5.5±0.5N·m

ELECTRICAL CHARACTERISTICS

Item	Symbol	Unit	Min.	Typ.	Max.	Test Conditions	
Collector Emitter Cut-Off Current	I _{CES}	mA	-	-	25	V _{CE} =6,500V, V _{GE} =0V, T _j =25°C	
Gate Emitter Leakage Current	I _{GES}	nA	-500	-	+500	V _{GE} =±20V, V _{CE} =0V, T _j =125°C	
Collector Emitter Saturation Voltage	V _{CE(sat)}	V	-	3.2	-	I _C =750A, V _{GE} =15V, T _j =25°C	
			3.4	4.3	5.2	I _C =750A, V _{GE} =15V, T _j =125°C	
Gate Emitter Threshold Voltage	V _{GE(TO)}	V	5.8	6.3	6.8	V _{CE} =10V, I _C =750mA, T _j =25°C	
Input Capacitance	C _{ies}	nF	-	130	-	V _{CE} =10V, V _{GE} =0V, f=100kHz, T _j =25°C	
Internal Gate Resistance	R _{ge}	Ω	-	0.7	-	V _{CE} =10V, V _{GE} =0V, f=100kHz, T _j =25°C	
Switching Times	Rise Time	t _r	μs	2.2	3.2	4.8	V _{CC} =3,600V, I _C =750A
	Turn On Time	t _{on}		2.7	3.9	5.9	L _s =200nH
	Fall Time	t _f		2.2	3.1	4.7	R _G =8.2Ω (3)
	Turn Off Time	t _{off}		4.5	6.4	9.6	V _{GE} =+/-15V, T _j =125°C
Peak Forward Voltage Drop	V _{FM}	V	-	3.6	-	I _F =750A, V _{GE} =0V, T _j =25°C	
			3.5	3.9	4.4	I _F =750A, V _{GE} =0V, T _j =125°C	
Reverse Recovery Time	t _{rr}	μs	-	0.8	1.6	V _{CC} =3600V, I _F =750A, L _s =200nH T _j =125°C	
Short Circuit Pulse Width	t _{sc}	μs	10	-	-	V _{CC} =4500V, L _s =200nH R _G (on/off)=8.2/82Ω, V _{GE} =±15V, T _j =25°C	
Turn On Loss	E _{on(10%)}	J/p	-	4.9	6.4	V _{CC} =3600V, I _C = I _F =750A, L _s =200nH R _G = 8.2Ω (3) V _{GE} =+/-15V, T _j =125°C	
	E _{on(full)}		-	5.5	-		
Turn Off Loss	E _{off(10%)}	J/p	-	3.9	5.1		
	E _{off(full)}		-	4.2	-		
Reverse Recovery Loss	E _{rr(10%)}	J/p	-	2.1	2.7		
	E _{rr(full)}		-	2.3	-		

Notes:(3) R_G value is the test condition's value for evaluation of the switching times, not recommended value.

Please, determine the suitable R_G value after the measurement of switching waveforms (overshoot voltage, etc.) with appliance mounted.

* Please contact our representatives at order.

* For improvement, specifications are subject to change without notice.

* For actual application, please confirm this spec sheet is the newest revision.

MBN750H65E2

THERMAL CHARACTERISTICS

Item		Symbol	Unit	Min.	Typ.	Max.	Test Conditions
Thermal Impedance	IGBT	Rth(j-c)	K/W	-	-	0.009	Junction to case
	FWD	Rth(j-c)		-	-	0.017	
Contact Thermal Impedance		Rth(c-f)	K/W	-	0.005	-	Case to fin ($\lambda_{grease}=1W/(m \cdot K)$, heat-sink flatness $\leq 50\mu m$)

MODULE MECHANICAL CHARACTERISTICS

Item		Unit	Characteristics	Conditions
Weight		g	1,550	
Stray inductance in module	LS(CM-EM)	nH	14	Collector-main to Emitter-main
Comparative Tracking Index (CTI)			600	
Module base plate Material			Al-SiC	
Baseplate Thickness		mm	5	
Insulation plate Material			Al N	
Terminal Surface treatment			Ni plating	
Case Material			Poly-Phenilene Sulfide	
Fire and Smoke Category			I2 / F3	NFF 16-102

MBN750H65E2

DEFINITION OF TEST CIRCUIT

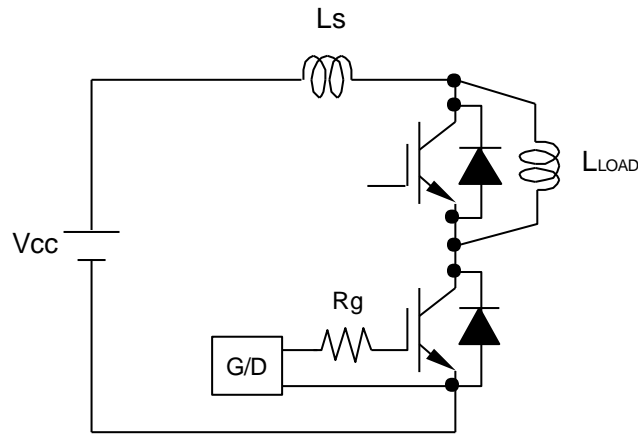


Fig.1 Switching test circuit

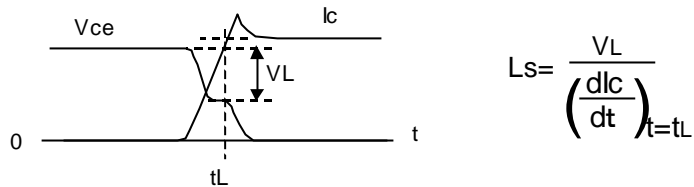


Fig.2 Definition of Ls

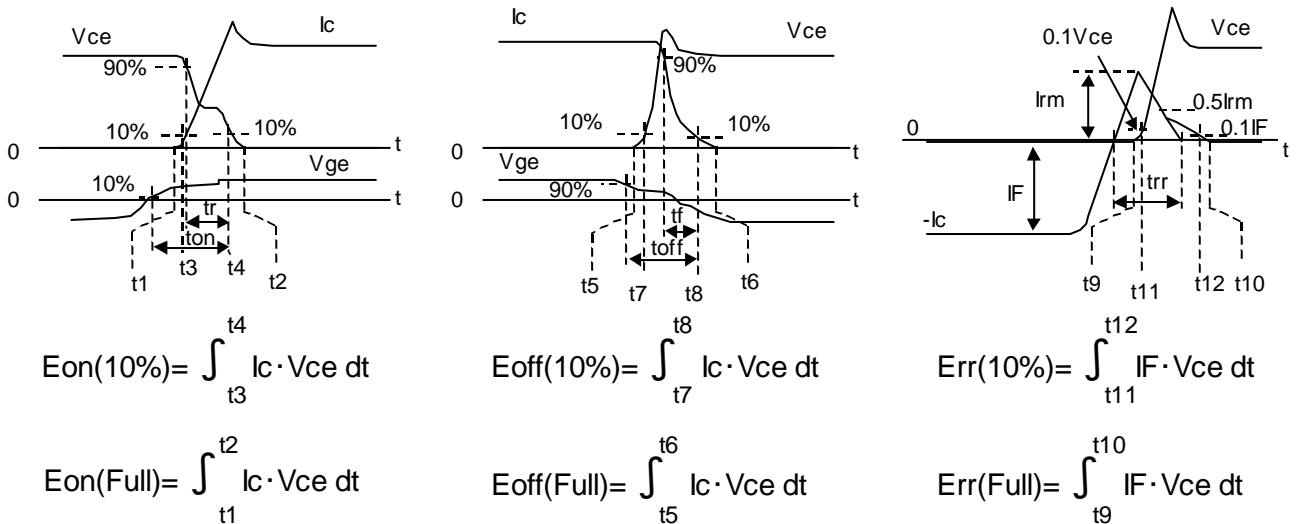
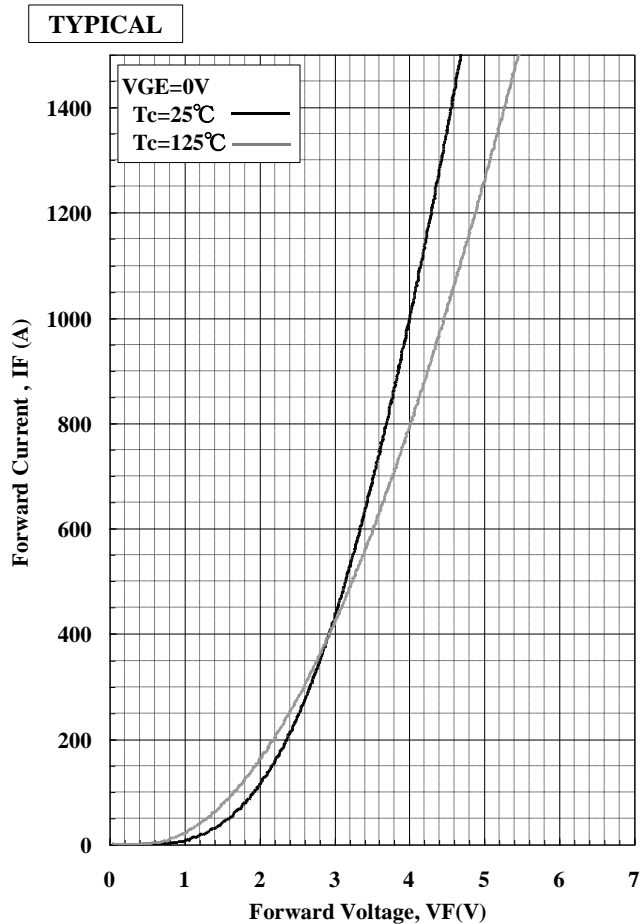
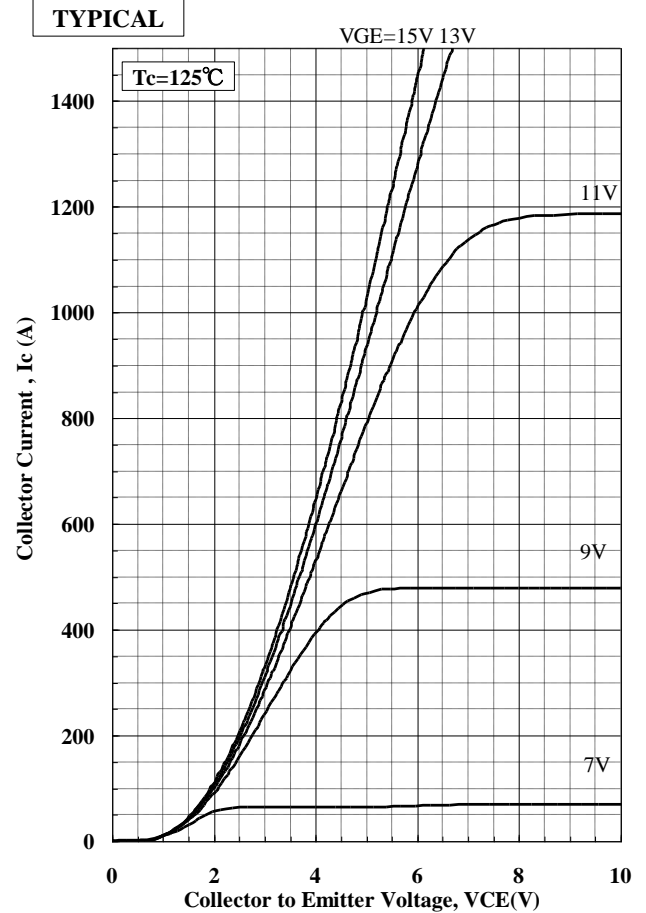
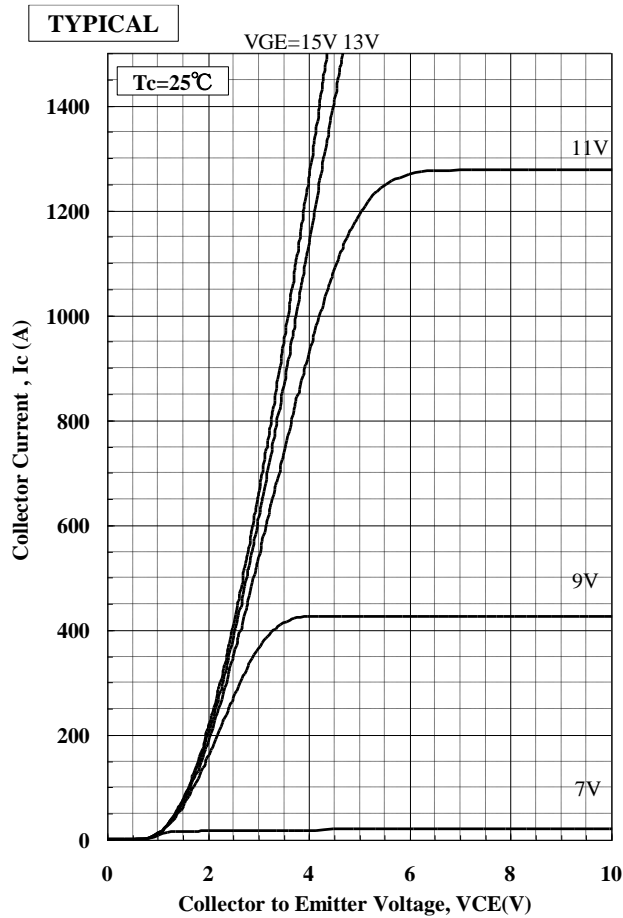


Fig.3 Definition of switching loss

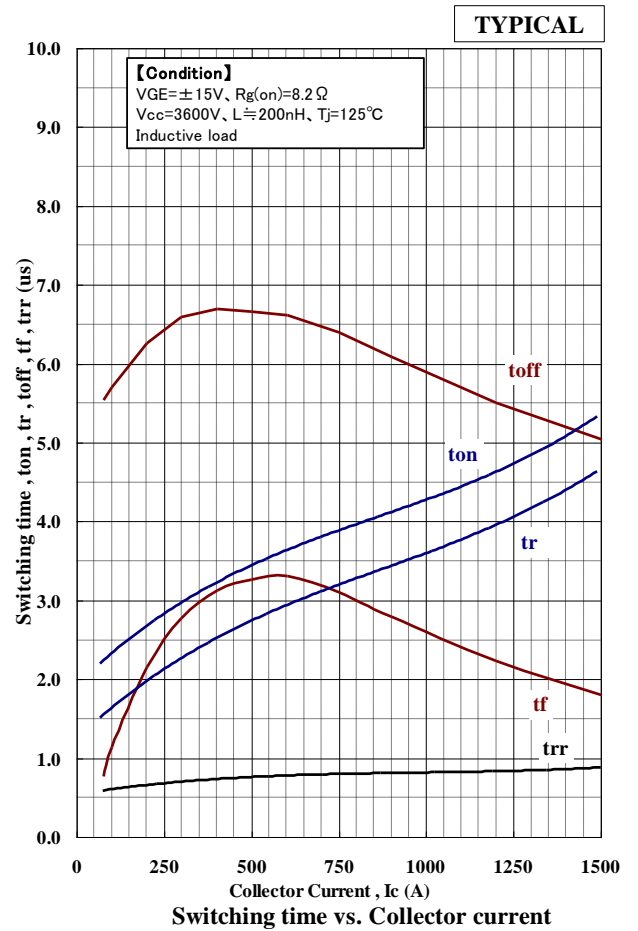
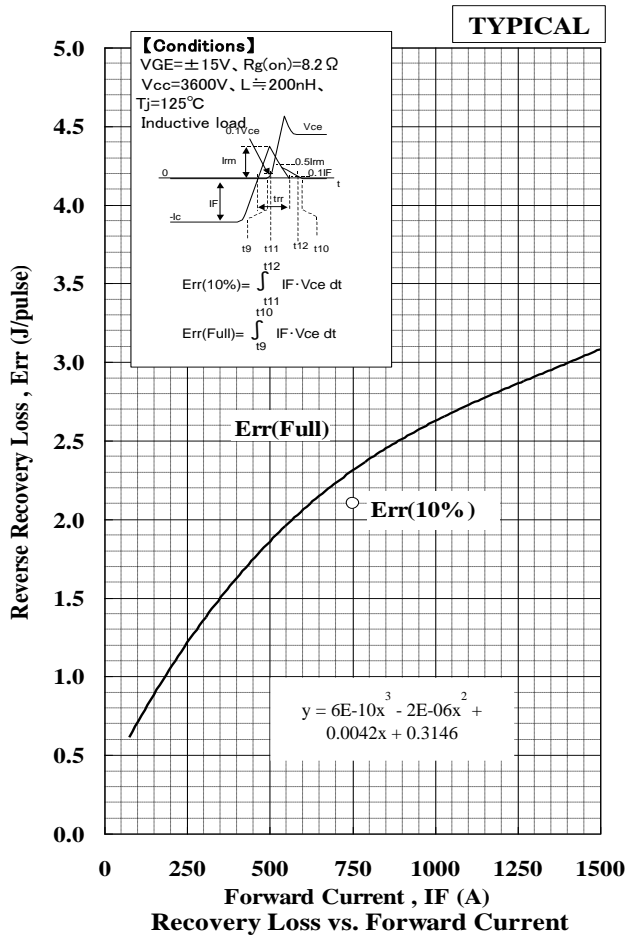
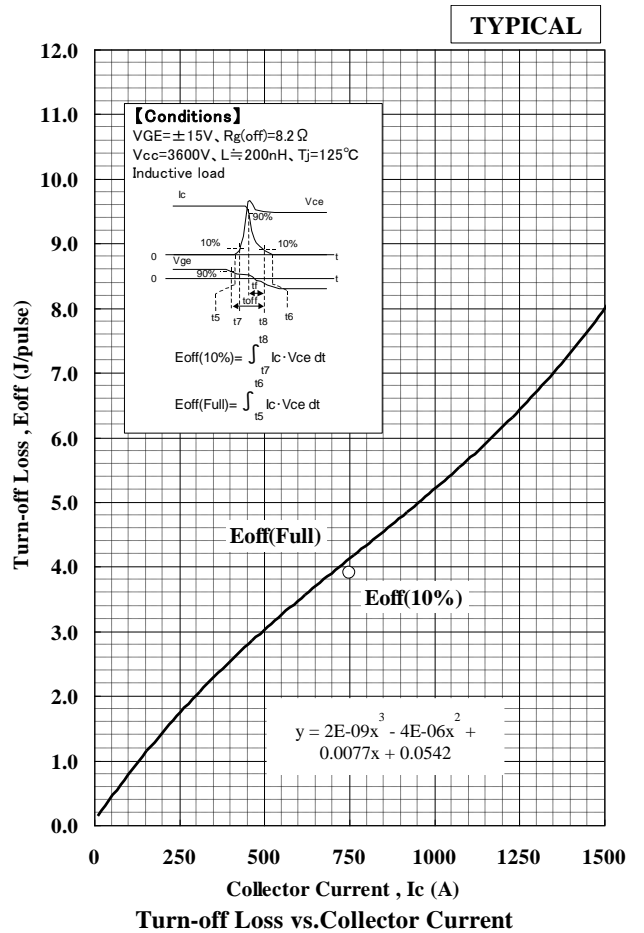
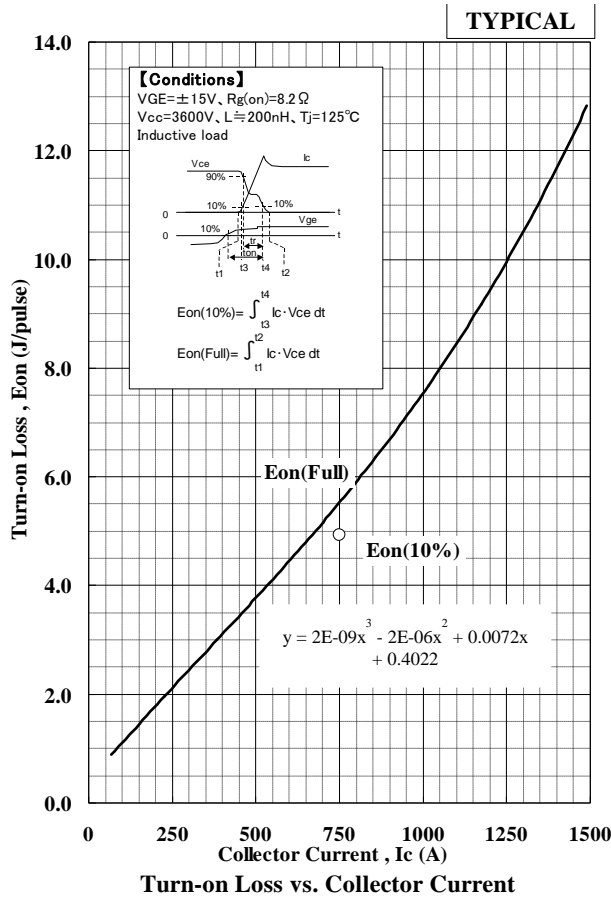
MBN750H65E2

STATIC CHARACTERISTICS



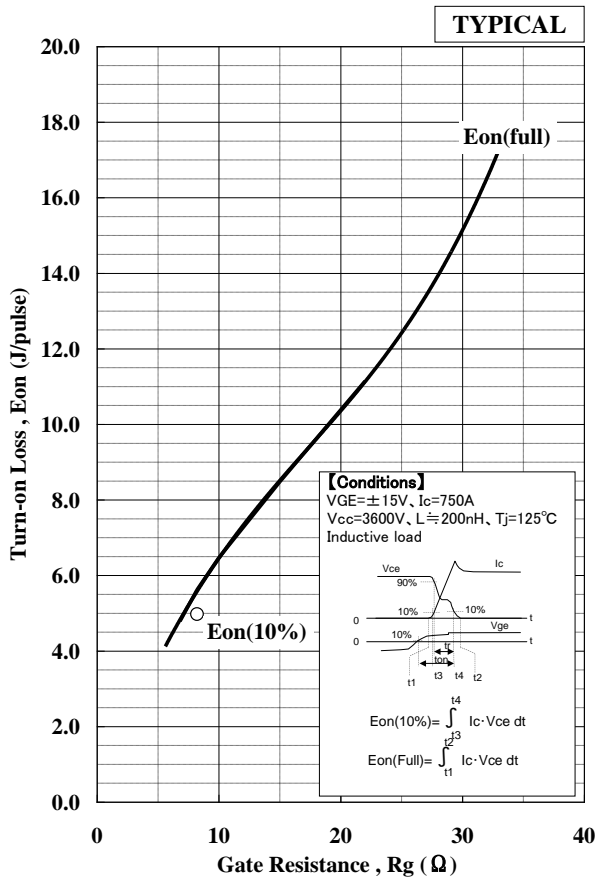
MBN750H65E2

DYNAMIC CHARACTERISTICS

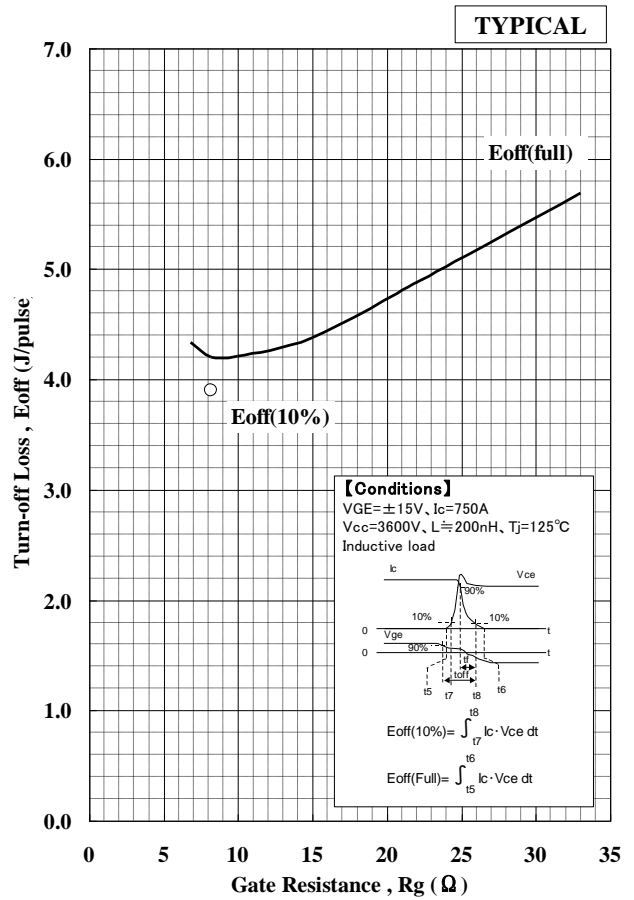


MBN750H65E2

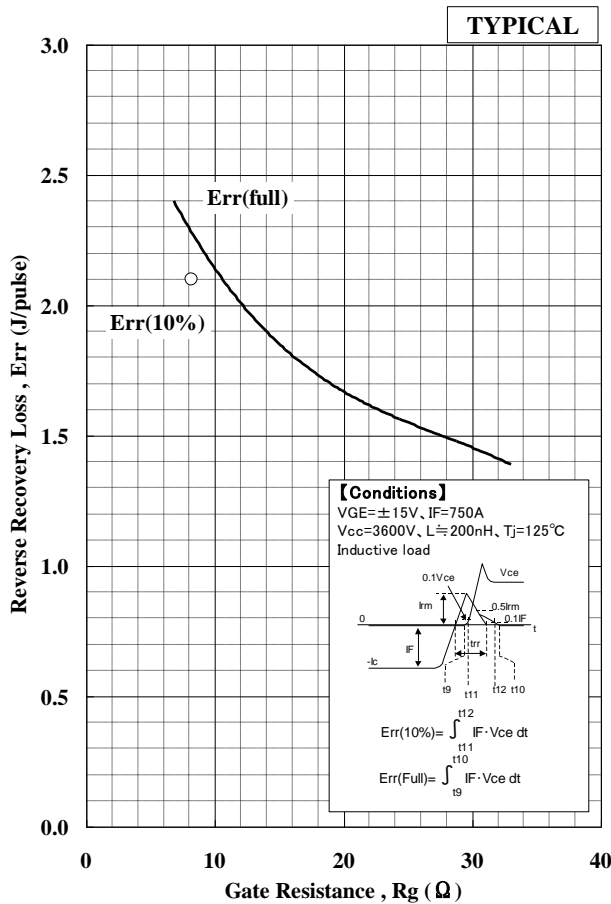
DYNAMIC CHARACTERISTICS



Turn-on Loss vs. Gate Resistance



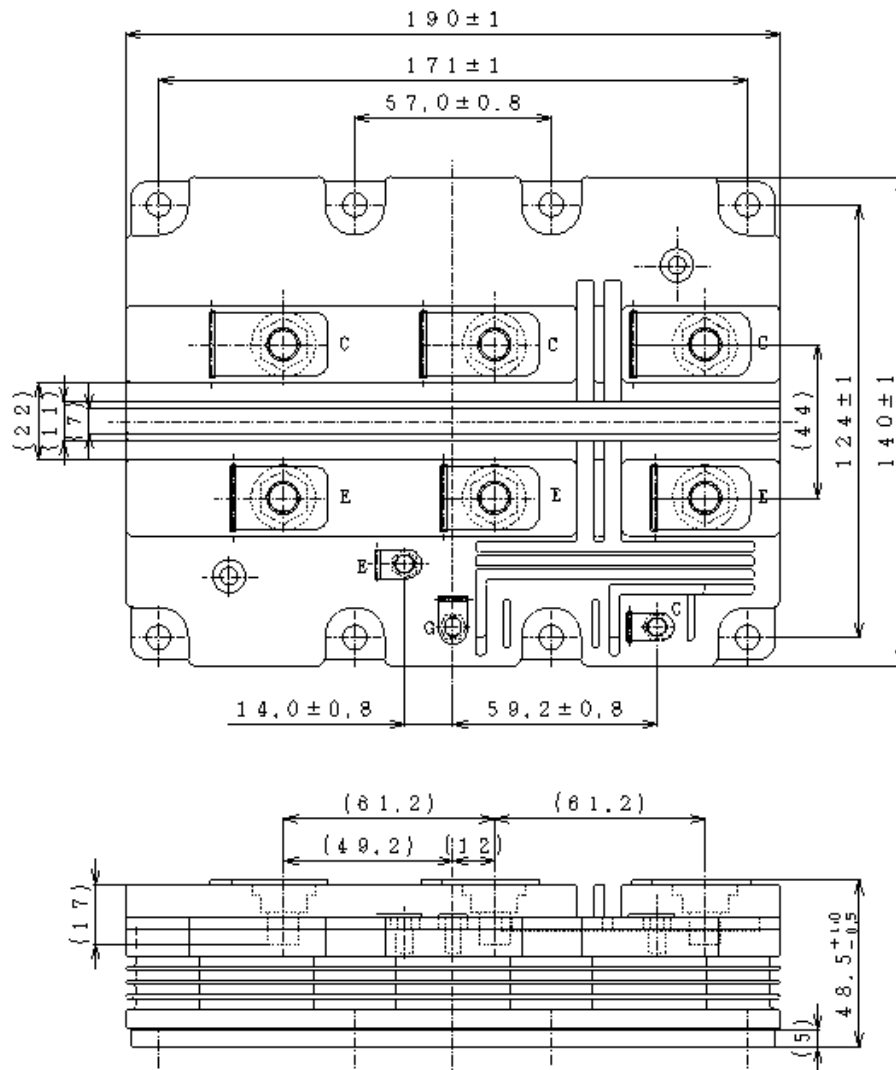
Turn-off Loss vs. Gate Resistance



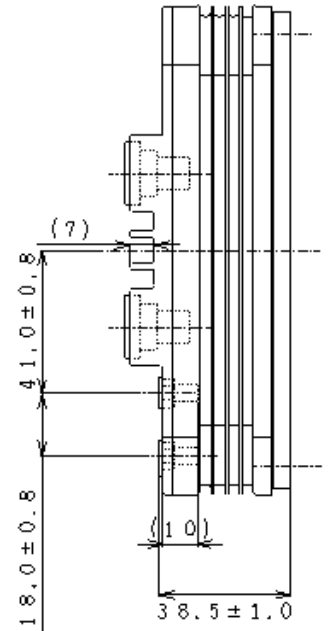
Recovery Loss vs. Gate Resistance

MBN750H65E2

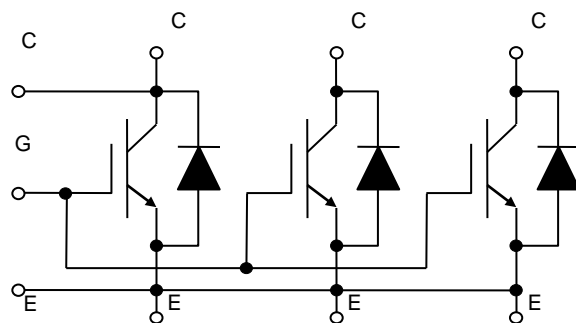
PACKAGE OUTLINE DRAWING



Unit in mm



CIRCUIT DIAGRAM



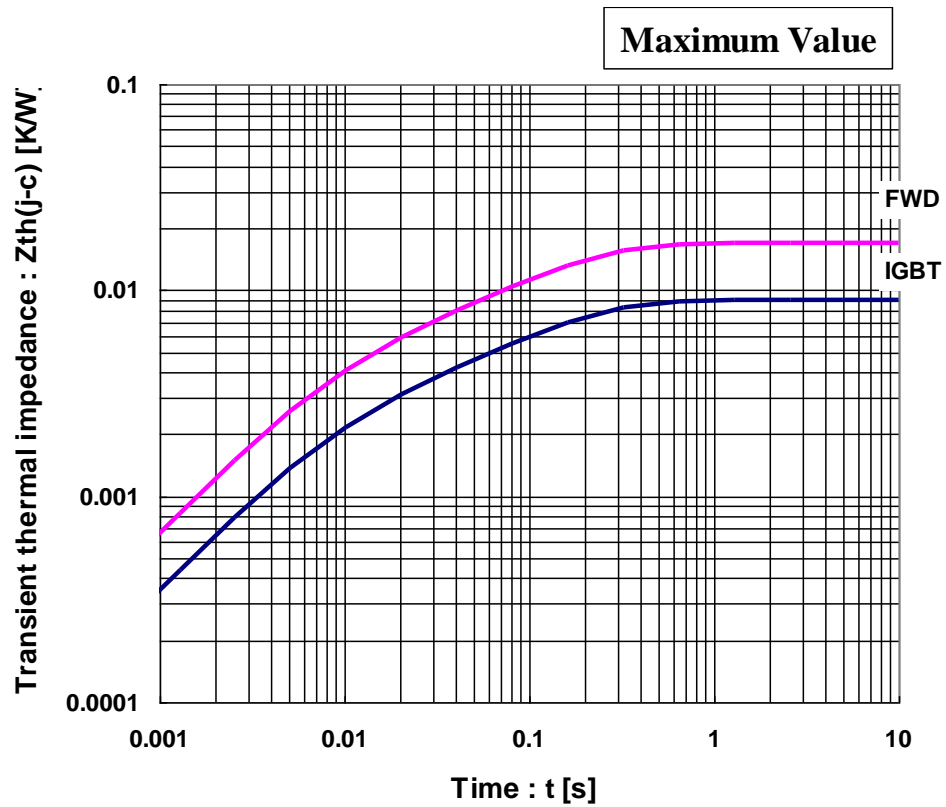
Material declaration

Please note the following materials are contained in the product, in order to keep characteristic and reliability level.

Material	Contained part
Lead (Pb) and its compounds	Solder

MBN750H65E2

THERMAL IMPEDANCE



Transient Thermal Impedance Curve

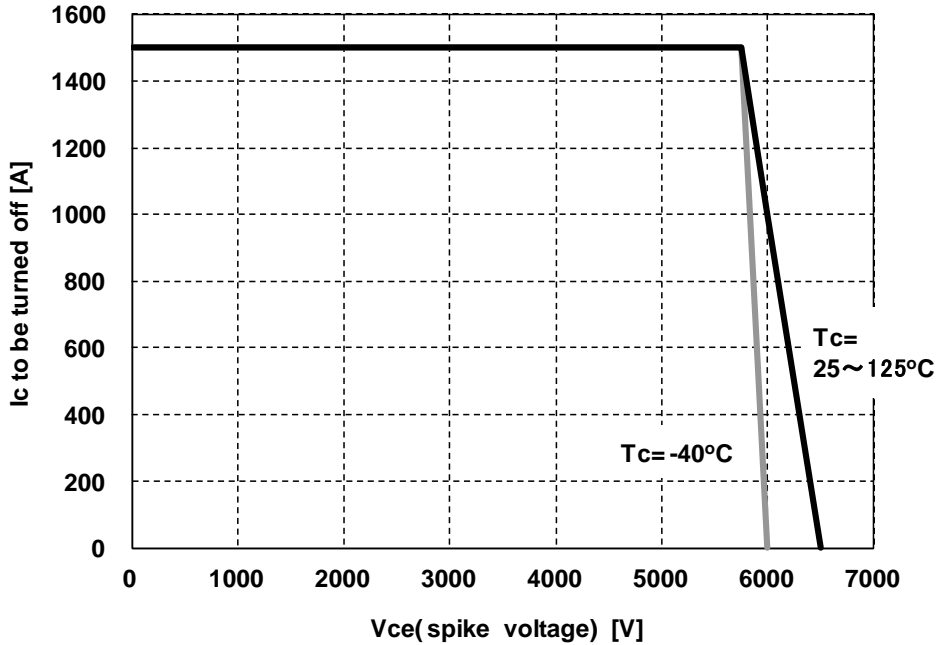
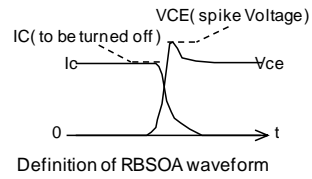
Curve approximation model
 $Z_{th} = \sum r_{th}[n] * (1 - \exp(-t/\tau_{th}[n]))$

n	1	2	3	4	Unit
$\tau_{th}[n]$	1.64E-01	2.75E-02	6.69E-03	7.42E-04	sec
$r_{th}[n,IGBT]$	5.61E-03	1.78E-03	1.56E-03	4.97E-05	K/W
$r_{th}[n,Diode]$	1.06E-02	3.41E-03	2.92E-03	1.00E-04	K/W

MBN750H65E2

RBSOA

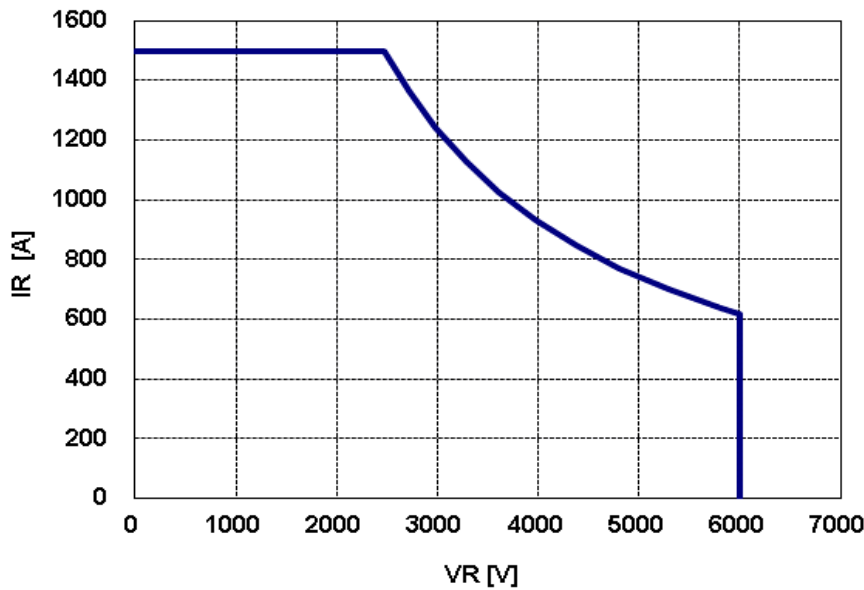
Conditions: $L_s \leq 200\text{nH}$, $V_{cc} \leq 4400\text{V}$,
 $I_c \leq 1500\text{A}$, $V_{GE} = \pm 15\text{V}$,
 $R_{g(\text{on/off})} \geq 8.2/8.2\Omega$, $-40^\circ\text{C} \leq T_c \leq 125^\circ\text{C}$
 on pulse width $\geq 20\mu\text{s}$
 (V_{ce} spike voltage and L_s are defined
 at auxiliary terminal)



Reverse bias safe operation area (RBSOA)

Recovery SOA

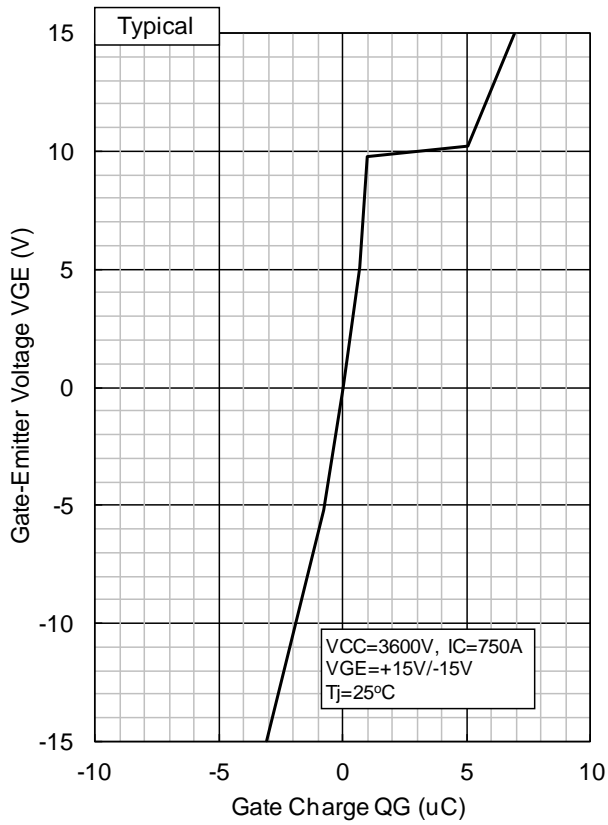
Conditions:
 $L_s \leq 200\text{nH}$, $V_{cc} \leq 4400\text{V}$, $I_F \leq 1500\text{A}$, $V_{GE} = -15\text{V}$,
 $R_{g(\text{on})}$ of across IGBT $\geq 8.2\Omega$, V_{GE} of across IGBT = $\pm 15\text{V}$,
 $-40^\circ\text{C} \leq T_c \leq 125^\circ\text{C}$, V_R defined at auxiliary terminal,
 Conduction pulse width of diode $\geq 30\mu\text{s}$



RecSOA

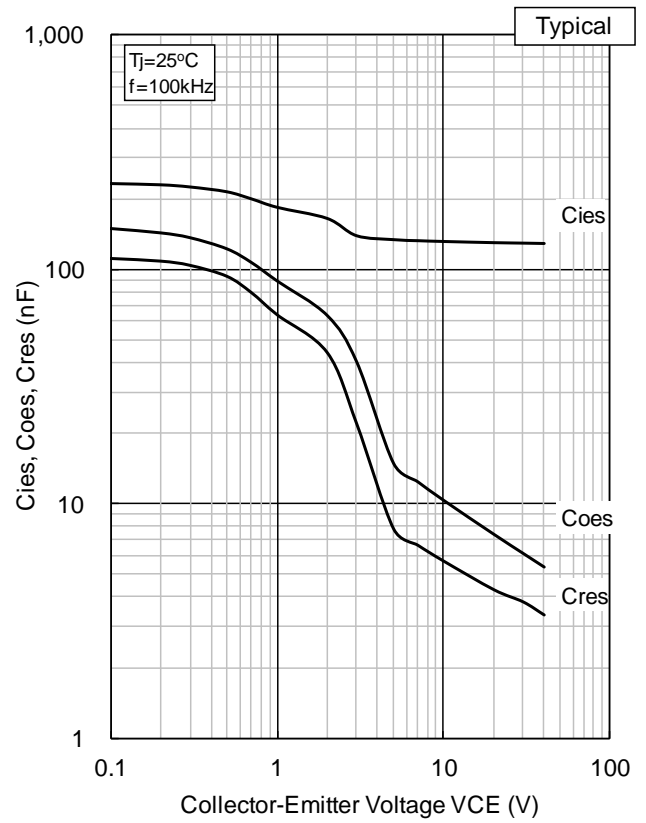
MBN750H65E2

QG-VGE CURVE



QG - VGE

Cies, Coes, Cres Curve



Cies, Coes, Cres - VCE

MBN750H65E2

HITACHI POWER SEMICONDUCTORS

Notices

1. The information given herein, including the specifications and dimensions, is subject to change without prior notice to improve product characteristics. Before ordering, purchasers are advised to contact Hitachi sales department for the latest version of this data sheets.
2. Please be sure to read "Precautions for Safe Use and Notices" in the individual brochure before use.
3. In cases where extremely high reliability is required (such as use in nuclear power control, aerospace and aviation, traffic equipment, life-support-related medical equipment, fuel control equipment and various kinds of safety equipment), safety should be ensured by using semiconductor devices that feature assured safety or by means of users' fail-safe precautions or other arrangement. Or consult Hitachi's sales department staff.
4. In no event shall Hitachi be liable for any damages that may result from an accident or any other cause during operation of the user's units according to this data sheets. Hitachi assumes no responsibility for any intellectual property claims or any other problems that may result from applications of information, products or circuits described in this data sheets.
5. In no event shall Hitachi be liable for any failure in a semiconductor device or any secondary damage resulting from use at a value exceeding the absolute maximum rating.
6. No license is granted by this data sheets under any patents or other rights of any third party or Hitachi Power Semiconductor Device, Ltd.
7. This data sheets may not be reproduced or duplicated, in any form, in whole or in part, without the expressed written permission of Hitachi Power Semiconductor Device, Ltd.
8. The products (technologies) described in this data sheets are not to be provided to any party whose purpose in their application will hinder maintenance of international peace and safety not are they to be applied to that purpose by their direct purchasers or any third party. When exporting these products (technologies), the necessary procedures are to be taken in accordance with related laws and regulations.

-
- For inquiries relating to the products, please contact nearest overseas representatives that is located "Inquiry" portion on the top page of a home page.
-

Hitachi power semiconductor home page address <http://www.hitachi-power-semiconductor-device.co.jp/en/>